

Notice of References Cited

Application/Control No.

09/475,319

Applicant(s)/Patent Under

Reexamination

DUPERROUZEL ET AL.

Examiner

Nhon (Gary) D Nguyen

Art Unit

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6072474	06-2000	Morimura, Takeshi et al.	345/173
	B	US-5499334	03-1996	Staab, Sanford A.	345/778
	C	US-			
	D	US-			
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	F	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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